APPLICATION

PATENT 584248

MPSRESCIENTE 23 JUN 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:)
CHRETIEN, Jean-Loup.) Group Art No. TBA
Serial No: TBA) Examiner: TBA
Filed: even herewith) Docket No. 007067.00001

For: ANTI-GLARE DEVICE, METHOD AND ACCESSORY, AND IMAGING SYSTEM WITH INCREASED BRIGHTNESS DYNAMICS

INFORMATION DISCLOSURE STATEMENT

U.S. Patent and Trademark Office Customer Service Window, Mail Stop New Application Randolph Building 401 Dulany Street Alexandria, VA 22314

Sir:

Pursuant to 37 C.F.R. §1.56 and in compliance with 37 C.F.R. §1.97, enclosed is Form PTO 1449 listing documents for consideration and entry by the Examiner in the above-captioned patent application. Entry and consideration of the cited information is respectfully requested together with a return of the Form PTO 1449 initialed by the Examiner indicating the same. A copy of the cited non-U.S. document is being submitted herewith.

If the Patent and Trademark Office determines that a fee is required, please charge our Deposit Account No. 19-0733.

Respectfully submitted,

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38 TBA 48 USPTO Form 1449 U.S. Department of Commerce Attorney Docket No. Patent and Trademark Office 007067.00001 INFORMATION DISCLOSURE CITATION Applicant(s): CHRETIEN, Jean-Loup Sheet 1 of 1 Filing Date: Group: TBA **U.S. PATENT DOCUMENTS** Examiner Patent No. Date Name Class Subclass Filing Date Initial (if appropriate) US 2002/012064 31 January 2002 **YAMAGUCHI** US 2002/071185 13 June 2002 LU et al. US 4 918 534 A 17 April 1990 LAM et al. FOREIGN PATENT DOCUMENTS Examiner Document No. Date Country Class Subclass Translation Initial YES NO FR 2 732 849 A 11 October 1996 France Abstract OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.) **DATE CONSIDERED EXAMINER** *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with

next communication to Applicant.